

## **Infrared Encoder/Decoder**

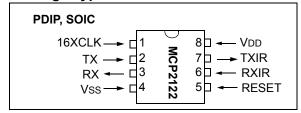
### **Features**

- · Pinout compatible with HSDL-7000
- Compliant with IrDA<sup>®</sup> Standard Physical Layer Specification (version 1.3)
- · UART to IrDA Standard Encoder/Decoder
  - Interfaces with IrDA Standard Compliant Transceiver
- · Baud rates:
  - Up to IrDA standard 115.2 Kbaud operation
- Transmit/Receive formats (bit width) supported:
  - 1.63 µs
- Low-power mode (2 μA at 1.8V, +125°C)

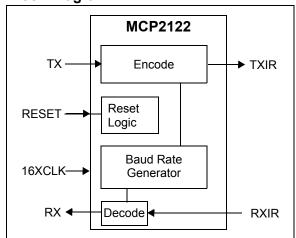
### **CMOS Technology**

- · Low-voltage operation
- · Extended temperature range
- · Low power consumption

### **Package Types**



### **Block Diagram**



### IrDA Family Selection

	Baud Rate		Encoder/	Protocol	Clock	Host UART		
Device	Host UART	IR	Decoder	l aver		Baud Rate Selection	Comment	
MCP2120	2400 - 312,500 <sup>(1)</sup>	2400 - 312,500 <sup>(1)</sup>	Yes	No	XTAL	HW/SW		
MCP2122	2400 - 115,200 <sup>(1)</sup>	2400 - 312,500 <sup>(1)</sup>	Yes	No	16XCLK	By 16XCLK	Extended Temperature Range (-40°C to +125°C)	
MCP2140	9600	9600	Yes	IrCOMM (3)	XTAL	None -Fixed		
MCP2150	9600 - 115,200 <sup>(2)</sup>	9600 - 115,200 <sup>(2)</sup>	Yes	IrCOMM (3)	XTAL	HW	Host UART easily interfaces to a PC's serial port (DTE)	
MCP2155	9600 - 115,200 <sup>(2)</sup>	9600 - 115,200 <sup>(2)</sup>	Yes	IrCOMM (3)	XTAL	HW	Host UART easily interfaces to a modem's serial port (DCE)	

- Note 1: The host UART and the IR operate at the same baud rates.
  - 2: The host UART baud rate and the IR baud rates operate independent of each other.
  - 3: Supports the 9-wire "cooked" service class of the IrCOMM Application Layer Protocol.

NOTES:

### 1.0 DEVICE OVERVIEW

The MCP2122 is a stand-alone IrDA standard encoder/decoder device that is pinout-compatible with the Agilent® HSDL-7000 Encoder/Decoder.

The MCP2122 has two interfaces: the host UART interface and the IR interface (see Figure 1-1). The host UART interfaces to the UART of the host controller. The host controller is the device in the embedded system that transmits and receives the data. The IR interface connects to an infrared (IR) optical transceiver circuit, which converts electrical pulses into IR light (encode) and converts IR light into electrical pulses (decode). This IR optical transceiver circuit could be either a standard infrared (IR) optical transceiver (such as a Vishay® TFDU 4100) or it could be implemented with discrete components. For additional information, please refer to Application Note 243, "Fundamentals of the Infrared Physical Layer" (DS00243).

When the host controller transmits the UART format data, the MCP2122 receives this UART data and encodes (modulates) the data bit by bit. This encoded data is then output as electrical pulses to the IR Transceiver. The IR transceiver will then convert these electrical pulses to IR light pulses.

The IR Transceiver also receives IR light pulses (data), which are outputted as electrical pulses. The MCP2122 decodes (demodulates) these electrical pulses, with the data then transmitted by the MCP2122 UART. This modulation and demodulation method is performed in accordance with the IrDA standard.

Table 1-1 shows an overview of some of the device features. Figure 1-1 shows a typical application block diagram. Table 1-2 shows the pin definitions of the MCP2122 in normal operation.

TABLE 1-1: MCP2122 FEATURES OVERVIEW

Features	MCP2122						
Serial Communications:	UART, IR						
Baud Rate Selection:	16XCLK						
Low Power Mode:	Yes						
Resets: (and Delays)	RESET pin (none)						
Packages:	8-pin PDIP 8-pin SOIC						

Infrared Technology Features:

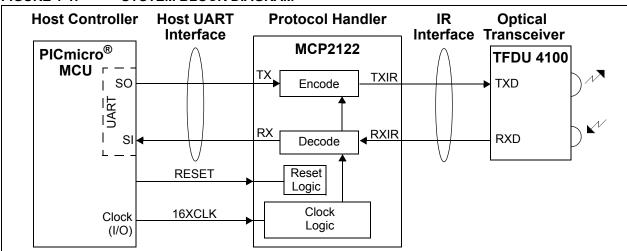
- Universal standard for connecting portable computing devices
- · Easy, effortless implementation
- Economical alternative to other connectivity solutions
- · Reliable, high speed connection
- Safe to use in any environment; can even be used during air travel
- · Eliminates the hassle of cables
- Allows PC's and non-PC's to communicate to each other
- Enhances mobility by allowing users to easily connect

### 1.1 Applications

Some applications where an IR interface (MCP2122) could be used include:

- · Data Logging/Data Exchange
- System Setup
- · System Diagnostic Read Out
- Manufacturing Configuration
- · Host Controller Firmware Updates
- · System Control

FIGURE 1-1: SYSTEM BLOCK DIAGRAM



**PIN DESCRIPTION TABLE 1-2:** 

Din Nama	Pin N	umber	Pin	Buffer						
Pin Name	PDIP	SOIC	OIC Type Ty		Description					
16XCLK	1	1	I	ST	16x external clock source input					
TX	2	2	I	ST	Asynchronous receive from host controller UART					
RX	3	3	0	_	Asynchronous transmit to host controller UART					
Vss	4	4	_	Р	Ground reference for logic and I/O pins					
RESET	5	5	I	ST	Resets the Device H = Normal Operation L = Device in Reset					
RXIR	6	6	I	ST	Asynchronous receive from infrared transceiver					
TXIR	7	7	0	_	Asynchronous transmit to infrared transceiver					
Vdd	8	8	_	Р	Positive supply for logic and I/O pins					

Legend: ST = Schmitt Trigger input with CMOS levels I = Input P = Power O = Output

### 2.0 DEVICE OPERATION

The MCP2122 is a low-cost infrared encoder/decoder. The baud rate is the same for the host UART and IR interfaces and is determined by the frequency of the 16XCLK signal, with a maximum baud rate of 115.2 Kbaud.

The MCP2122 is made up of these functional modules:

- Clock Driver (16XCLK)
- Reset
- IR Encoder/Decoder
  - IrDA Standard Encoder
  - IrDA Standard Decoder

The **16XCLK** circuit allows a clock input to provide the device clock.

The **Reset** circuit supports an external reset signal.

The IR Encoder logic takes a data bit and converts it to the IrDA signal according to the IrDA Standard Physical Layer specification, while the IR Decoder logic takes the IrDA standard signal and converts it to 8-bit data bytes.

### 2.1 Power-up

As the device is powered up, there will be a voltage range where the device will not operate properly. The device should be reset once the device has entered the normal operating range (from an out-of-voltage condition). The RESET pin may then be forced high.

Other device operating parameters (such as frequency, temperature, etc.) must also be within their operating ranges when the device exits reset. Otherwise, the device may not function as desired.

### 2.2 Device Reset

The MCP2122 is forced into the known state (RESET) when the RESET pin is in the low state. Once the RESET pin is brought to a high state, the device begins normal operation (if the device operating parameters are met). Table 2-1 shows the states of the output pins while the device is in reset (RESET = Low). Table 2-2 shows the state of the output pins once the device exits reset, RESET =  $L \rightarrow H$  (device in Normal Operation mode).

The MCP2122 has a RESET noise filter in the RESET input signal path. The filter will detect and ignore small pulses.

Using the RESET pin to enter a low-power state is discussed in **Section 2.9 "Minimizing Power"**.

TABLE 2-1: DEFAULT OUTPUT PIN STATES IN DEVICE RESET

Input	Pin		ut Pin ate	Comments	
Name	ne State RX TXIR		TXIR		
RESET	L	Η	L	Device in Reset mode	

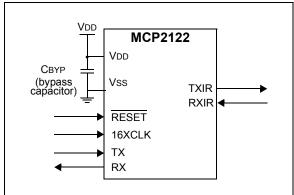
TABLE 2-2: DEFAULT OUTPUT PIN STATES AFTER DEVICE RESET (RESET =  $L\rightarrow H$ )

Input	t Pin	Output Pin State		Comments
Name	State	RX	TXIR	
TX	L	_	L→H →L	After 7 - 8 16XCLK pulses, the TXIR pin will pulse high.
	Н	_	L	
RXIR	L	H→L	_	After 4 16XCLK pulses, RX = L.
	Н	Н		

### 2.3 Decoupling

It is highly recommended that the MCP2122 have a decoupling capacitor ( $C_{BYP}$ ). A 0.01  $\mu F$  capacitor is recommended as a starting value, but evaluation of the best value for your circuit/layout should be done. Place this decoupling capacitor ( $C_{BYP}$ ) as close to the MCP2122 as possible (see Figure 2-1).

FIGURE 2-1: DEVICE DECOUPLING



### 2.3.1 BROWN-OUTS

Some applications may subject the MCP2122 to a brown-out condition. Good design practice requires that when a system is in brown-out, the system should be in reset to ensure that the system is in a known state when the system exits the brown-out. This brown-out circuitry is external to the MCP2122.

### 2.3.1.1 External Brown-Out Reset Circuits

Figure 2-2 shows a circuit for external brown-out protection using the TCM809 device.

Figure 2-3 and Figure 2-4 illustrate two examples of external circuitry that may be implemented. Each option needs to be evaluated to determine if they satisfy the requirements of the application.

FIGURE 2-2: EXTERNAL BROWN-OUT PROTECTION USING THE TCM809

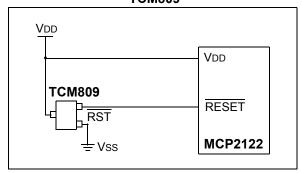
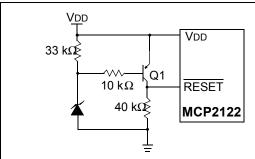
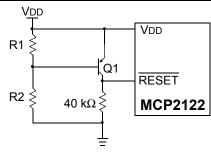


FIGURE 2-3: EXTERNAL BROWN-OUT PROTECTION CIRCUIT 1



- **Note 1:** Resistors should be adjusted for the characteristics of the transistor.
  - 2: This circuit will activate reset when VDD goes below (Vz + 0.7V), where Vz = Zener voltage.

## FIGURE 2-4: EXTERNAL BROWN-OUT PROTECTION CIRCUIT 2



Note 1: This circuit is less expensive, but less accurate. Transistor Q1 turns off when VDD is below a certain level such that:

$$V_{DD} \cdot \frac{R1}{R1 + R2} = 0.7V$$

**2:** Resistors should be adjusted for the characteristics of the transistor.

### 2.4 16XCLK (Bit Clock)

The MCP2122 requires an external clock source to operate. The 16XCLK pin is the device clock input (see Figure 2-5) and is independent of the host UART interface or the IR interface. The 16XCLK determines all timing during device operation. It is the edge of the 16XCLK pin that causes activity to occur.

The 16XCLK signal can also be referred to as a bit clock (BITCLK). There are 16 BITCLKs for each bit time. The BITCLKs are used for the generation of the Start bit, the eight data bits and the Stop bit.

When the embedded system could be receiving IR communication, the MCP2122 is required to have the 16XCLK signal clocking at the expected frequency and have minimal variation in frequency. Between data bytes (Stop bit to Start bit), the 16XCLK frequency can be changed. This may occur in systems where the host controller is implementing one of the IrDA standard application layer protocols (such as IrObex).

When the embedded system does not want to receive IR communications, the 16XCLK clock can be disabled (static). This will reduce the power consumption of the system.

Figure 2-6 shows the relationship of the 16XCLK signal to the RXIR input, which then determines the RX output signal. Figure 2-7 shows the relationship of the 16XCLK signal to the TX input, which then determines the TXIR output signal. For device timing information, refer to Section 4.0 "Electrical Characteristics".

FIGURE 2-5: DEVICE CLOCK SOURCE

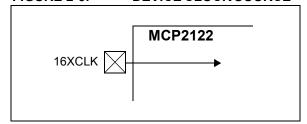


FIGURE 2-6: 16XCLK AND RX/RXIR

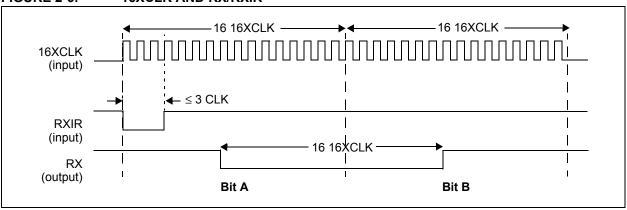
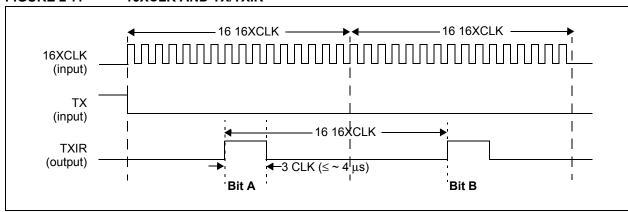


FIGURE 2-7: 16XCLK AND TX/TXIR



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### 2.4.1 BAUD RATE

The baud rate for the MCP2122 is determined by the frequency of the 16XCLK signal. Equation 2-1 demonstrates how to calculate the 16XCLK frequency based on the desired baud rate. Table 2-3 shows some common baud rates and the corresponding 16XCLK frequency.

**EQUATION 2-1: 16XCLK FREQUENCY** 

 $F_{16XCLK} = 16 \bullet (Desired Baud Rate)$ 

TABLE 2-3: COMMON BAUD RATE/ 16XCLK FREQUENCY

Baud Rate	16XCLK Frequency (F <sub>16xclk</sub> )	Comment
9600	153,600	
19,200	307,200	
38,400	614,400	
57,600	921,600	
115,200	1,843,200	

### 2.5 Encoder/Decoder

The IR Encoder/Decoder is made up of two major components. They are:

- · IR Decoder
- · IR Encoder

The encoder receives UART data (bit by bit) and outputs a data bit in the IrDA standard bit format. Figure 2-8 shows a functional block diagram of the encoder.

The decoder receives IrDA standard data (bit by bit) and outputs data in UART data bit format. Figure 2-8 shows a functional block diagram of the decoder.

The encoder/decoder has two interfaces. They are:

- · host UART interface
- · IR interface

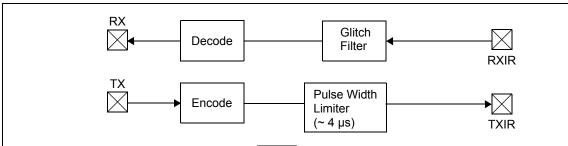
### 2.5.1 ENCODING (MODULATION)

Each bit time is comprised of 16 bit clocks. If the value to be transmitted (as determined by the TX pin) is a logic-low, the TXIR pin will output a low level for 7-bit clock cycles, a logic-high level for 3-bit clock (with a maximum high-time of about 4 µs) cycles, with the remaining time (6-bit clock cycles or more) being low. If the value to transmit is a logic-high, the TXIR pin will output a low level for the entire 16 bit clock cycle.

### 2.5.2 DECODING (DEMODULATION)

Each bit time is comprised of 16 bit clocks. If the value to be received is a logic-low, the RXIR pin will be a low level for the first 3-bit clock cycle (or a minimum of 1.6  $\mu$ s), with the remaining time (13-bit clock cycles) being high. If the value to be received is a logic high, the RXIR pin will be a high level for the entire 16 bit clock cycle. The level on the RX pin will be in the appropriate state for an entire 16-bit clock cycle.

FIGURE 2-8: MCP2122 RECEIVE DETECT TO ENCODER/DECODER BLOCK DIAGRAM



The following table shows the state on the RESET pin and how this effects the operation of the TXIR pin.

RESET State	Comment				
VIH	TXIR output encoded value of TX pin				
VIL	TXIR is forced low				

## 2.5.3 ENCODING AND SCREEN CAPTURES

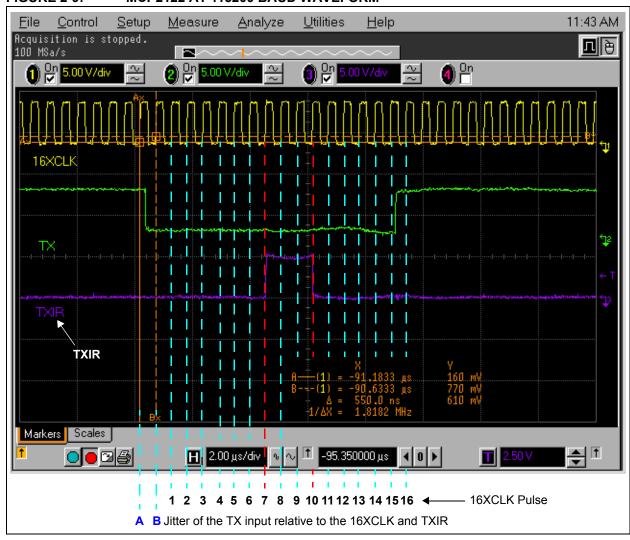
Table 2-4 shows the TXIR pin high-time at different common baud rates. The internal TXIR pulse width high-time limiter is a feature that minimizes the system current consumption at lower baud rates. The IrDA standard specification requires that optical receiver circuitry detect pulses as narrow as 1.41 µs (1.63 µs is the typical time at 115200 baud). Therefore, the time that the TXIR pin is high after this valid detection is additional current that is driven by the emitter LED. The MCP2122 will force the TXIR pin low after the pulse width limiter has timed out. Figure 2-9 shows the MCP2122 16XCLK, TX and TXIR waveforms at 115200 baud for a single TX low bit. In this case the TXIR is high for three 16XCLK pulses. In Figure 2-10 the MCP2122 is at 9600 baud for a single TX low bit. In this case the TXIR is high for 3.55 µs.

TABLE 2-4: TXIR HIGH PULSE WIDTH

	TXIR Pul	se Width			
Baud Rate	3xT <sub>16XCLK</sub>	Pulse Width Limiter <sup>(2)</sup>	Comment		
9600	19.53 µs	4.00 µs	Note 1		
19200	9.77 µs	4.00 µs	Note 1		
38400	4.88 µs	4.00 µs	Note 1		
46875	4.00 μs	4.00 µs	Target Crossover Point		
57600	3.26 µs	4.00 µs			
115200	1.63 µs	4.00 µs			

- **Note 1:** The pulse width limiter on the TXIR pin saves system current for this baud rate.
  - 2: This TXIR pulse width time is a design target and is not tested. Actual times may be greater than or less than this value.

FIGURE 2-9: MCP2122 AT 115200 BAUD WAVEFORM



Control 11:41 AM <u>F</u>ile Setup: <u>M</u>easure <u>A</u>nalyze <u>U</u>tilities <u>H</u>elp **□** 100 MSa/s 16XCLK \$ TXIR Markers Scales H 20.0 µs/div 🕠 🗸 📘 -99.450000 дз T 2.50 V 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 ← 16XCLK Pulse A B Jitter of the TX input relative to the 16XCLK and TXIR

FIGURE 2-10: MCP2122 AT 9600 BAUD WAVEFORM

### 2.6 Host UART Interface

The UART interface is used to communicate with the host controller. Though a UART is capable of a full-duplex interface, the direct coupling to the IR encoder/decoder allows only half-duplex operation (since the IR side is either receiving or transmitting and not both at the same time). This means that the system can not transmit and receive at the same time.

#### 2.6.1 TRANSMITTING

When the controller sends serial data to the MCP2122, the baud rates are required to match.

There will be some jitter on the detection of the high to low edge of the start bit. This jitter will affect the placement of the encoded start bit. All subsequent bits will be 16 BITCLK times later.

While RXIR is receiving data (low pulse), the TXIR pin is disabled from transmitting.

### 2.6.2 RECEIVING

When the controller receives serial data from the MCP2122, the baud rates are required to match.

There will be some jitter on the detection of the high-tolow edge of the Start bit. This jitter will affect the placement of the decoded Start bit. All subsequent bits will be 16 BITCLK times later.

The TXIR pin is disabled when data is being received (low pulse) on the RXIR pin.

### 2.7 IR Interface

The IR interface is used to communicate with the optical receiver circuitry. The IR interface is either transmitting data or receiving data (half-duplex).

## 2.8 Encoding/Decoding Jitter and Offset

Figure 2-11 shows the jitter on the RXIR and TX pins, and the offset on the RX pin and the TXIR pin.

Jitter is the possible variation of the desired edge. Figure 2-9 and Figure 2-10 show the jitter of the TX pin (range is indicated by red dashed lines).

Offset is the propagation delay of the input signal (RXIR or TX) to the output signal (RX or TXIR). Figure 2-9 and Figure 2-10 show the offset of the TXIR pin from the 16XCLK signal that starts the bit time.

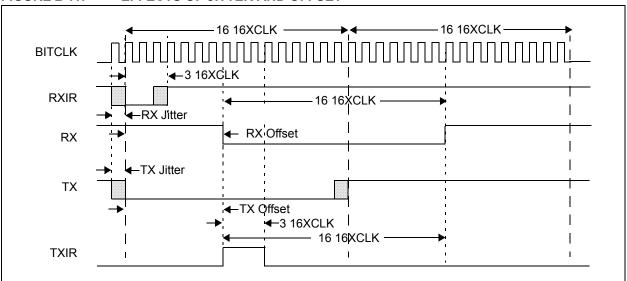
### 2.9 Minimizing Power

The device can be placed in a Low Power mode by forcing the RESET pin low. This disables the internal state machine. To ensure that the lowest power consumption is obtained, ensure that the 16XCLK pin is not active and that the other input pins (TX and RXIR) are at a logic-high or logic-low level.

### 2.9.1 RETURNING TO OPERATION

When returning to normal operation, the RESET pin must be forced high and the 16XCLK signal should be operating. Time should be given to ensure that the 16XCLK is stabilized at the desired frequency before data is allowed to be transmitted or received.

FIGURE 2-11: EFFECTS OF JITTER AND OFFSET



### 3.0 DEVELOPMENT TOOLS

There are currently no development tools for the MCP2122. A demo board is scheduled to be available soon.

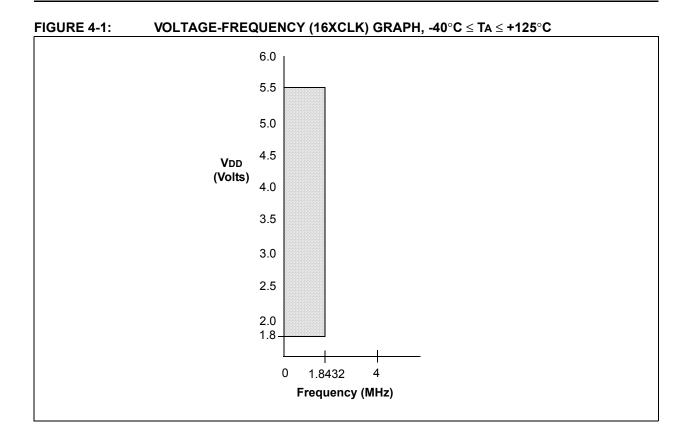
#### 4.0 **ELECTRICAL CHARACTERISTICS**

### **Absolute Maximum Ratings†**

Ambient Temperature under bias	40°C to +125°C
Storage Temperature	65°C to +150°C
Voltage on VDD with respect to Vss	0.3V to +6.5V
Voltage on RESET with respect to Vss	0.3V to +14V
Voltage on all other pins with respect to Vss	
Total Power Dissipation <sup>(1)</sup>	800 mW
Max. Current out of Vss pin	500 mA
Max. Current into VDD pin	500 mA
Input Clamp Current, IIK (VI < 0 or VI > VDD)	±20 mA
Output Clamp Current, IOK (V0 < 0 or V0 > VDD)	±20 mA
Max. Output Current sunk by any Output pin	25 mA
Max. Output Current sourced by any Output pin	25 mA
Note 1: Power Dissipation is calculated as follows:	

PDIS = VDD x {IDD -  $\sum$  IOH} +  $\sum$  {(VDD-VOH) x IOH} +  $\sum$ (VOL x IOL)

<sup>†</sup>NOTICE: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.



### 4.1 DC Characteristics

DC Characteristics			Standard Operating Conditions (unless otherwise specified) Operating Temperature: -40°C ≤ TA ≤ +125°C (Extended)					
Param. No.	Sym	Characteristic	Min	Typ <sup>(1)</sup>	Max	Units	Conditions	
D001	VDD	Supply Voltage	1.8	_	5.5	V	See Figure 4-1	
D010	IDD	Supply Current (2)	_	0.1	1	mA	Fosc = 1.8432 MHz, VDD = 5.5V (TX = H, RXIR = H)	
							Transmitter (TX = L, RXIR = H)	
			_	_	300	μΑ	Fosc = 1.8432 MHz, V <sub>DD</sub> = 1.8V <sup>(4)</sup>	
			_		1	mA	Fosc = 1.8432 MHz, VDD = 5.5V	
							Receiver (RXIR = L, TX = H)	
			_	_	500	μΑ	Fosc = 1.8432 MHz, VDD = 1.8V (4)	
			_	_	2	mA	Fosc = 1.8432 MHz, VDD = 5.5V	
D020	IPD	Device Disabled Current <sup>(3)</sup>	_	_	2	μΑ	VDD = 1.8V <sup>(4)</sup>	
			_	_	4	μΑ	VDD = 5.5V	

- **Note 1:** Data in the Typical ("Typ") column is based on characterization results at +25°C. This data is for design guidance only and is not tested.
  - **2:** The supply current is mainly a function of the operating voltage and frequency. Pin loading, pin rate and temperature have an impact on the current consumption.
    - a)The test conditions for all IDD measurements are:

      16XCLK = external square wave, from rail-to-rail; TX = Vss, RXIR = Vss, RESET = VDD.
  - **3:** The device disable current is mainly a function of the operating voltage. Temperature also has an impact on the current consumption. When the device is disabled (RESET = Vss). The test conditions for all IDD measurements are:
    - 16XCLK = external square wave, from rail-to-rail; TX = Vss, RXIR = VDD, RESET = Vss; The output pins are driving a high or low level into infinite impedance.
  - **4:** These parameters (shaded) are characterized but are not tested. These values should be used for design guidance only.

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### **DC Characteristics** (Continued)

DC CHAI	RACTER	ISTICS	Standard Operating Conditions (unless otherwise specified) Operating temperature $-40^{\circ}\text{C} \le \text{Ta} \le +125^{\circ}\text{C}$ (extended) Operating voltage VDD range as described in DC spec, Section 4.1 "DC Characteristics".						
Param No.	Sym	Characteristic	Min	Typ <sup>(1)</sup>	Max	Units	Conditions		
	VIL	Input Low Voltage Input pins							
D031		TX, RXIR	Vss	_	0.2 VDD	V			
D032		RESET	Vss	_	0.2 VDD	V			
D033		16XCLK	Vss	_	0.2 VDD	V			
	VIH	Input High Voltage							
		Input pins		_					
D041		TX, RXIR	0.8 VDD	_	VDD	V			
D042		RESET	0.8 VDD	_	VDD	V			
D043		16XCLK	0.8 VDD		VDD	V			
	lıL	Input Leakage Current <sup>(2, 3)</sup>							
D060A		TX, and 16XCLK	_	_	±1	μΑ	Vss ≤ Vpin ≤ Vdd, Pin at high-impedance		
D061		RESET	_	_	±1	μΑ	Vss ≤ Vpin ≤ Vdd		
D060B	Iн	RXIR	_	_	±1	μΑ	VDD = 5.5V, VRXIR = VDD		

**Note 1:** Data in the Typical ("Typ") column is based on characterization results at +25°C. This data is for design guidance only and is not tested.

<sup>2:</sup> The leakage current on the RESET pin is strongly dependent on the applied voltage level. The specified levels represent normal operating conditions. Higher leakage current may be measured at different input voltages.

<sup>3:</sup> Negative current is defined as coming out of the pin.

### **DC Characteristics** (Continued)

DC CHARACTERISTICS			Standard Operating Conditions (unless otherwise specified) Operating temperature: $-40^{\circ}\text{C} \le \text{Ta} \le +125^{\circ}\text{C}$ (Extended) Operating voltage VDD range as described in DC spec, Section 4.1 "DC Characteristics".				
Param No. Sym Characteristic			Min	Typ <sup>(1)</sup>	Max	Units	Conditions
	Vol	Output Low Voltage					
D080B		RX	_	_	0.6	V	IOL = 2 mA, VDD = 1.8V
D081		TXIR	_	_	0.6	V	IOL = 2 mA, VDD = 1.8V
	Vон	Output High Voltage					
D090B		RX <sup>(2)</sup>	VDD - 0.7	_	_	V	IOH = -0.8 mA, VDD = 1.8V
D091		TXIR (2)	VDD - 0.7	_	_	V	IOH = -0.8 mA, VDD = 1.8V
		Capacitive Loading Specs on Output Pins					
D101A	Cout	All Output pins	–	_	50	pF	
D101B	CIN	All Input pins	_	7	_	pF	TA = +25°C, Fc = 1.0 MHz

Note 1: Data in the Typical ("Typ") column is based on characterization results at +25°C. This data is for design guidance only and is not tested.

<sup>2:</sup> Negative current is defined as coming out of the pin.

### 4.2 Timing Parameter Symbology and Load Conditions

The timing parameter symbols have been created following one of the following formats:

### 4.2.1 TIMING CONDITIONS

The temperature and voltages specified in Table 4-2 apply to all timing specifications unless otherwise noted. Figure 4-2 specifies the load conditions for the timing specifications.

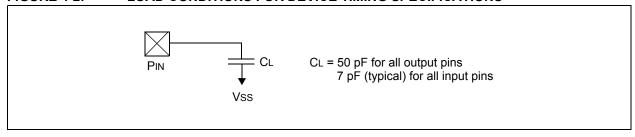
TABLE 4-1: SYMBOLOGY

1. TppS2pp	S	2. TppS	
T			
F	Frequency	Т	Time
Е	Error		
Lowercas	se letters (pp) and their meanings:		
pp			
io	Input or Output pin	xclk	Oscillator
rx	Receive	tx	Transmit
bitclk	RX/TX BITCLK	RST	Reset
Uppercas	se letters and their meanings:		
S			
F	Fall	Р	Period
Н	High	R	Rise
1	Invalid (Hi-impedance)	V	Valid
L	Low	Z	High-impedance

### TABLE 4-2: AC TEMPERATURE AND VOLTAGE SPECIFICATIONS

AC CHARACTERISTICS	Standard Operating Conditions (unless otherwise stated)  Operating temperature: $-40^{\circ}\text{C} \le \text{TA} \le +125^{\circ}\text{C}$ (Extended)  Operating voltage VDD range as described in DC spec,  Section 4.1 "DC Characteristics".
--------------------	--

### FIGURE 4-2: LOAD CONDITIONS FOR DEVICE TIMING SPECIFICATIONS



### 4.3 Timing Diagrams and Specifications

FIGURE 4-3: EXTERNAL CLOCK TIMING

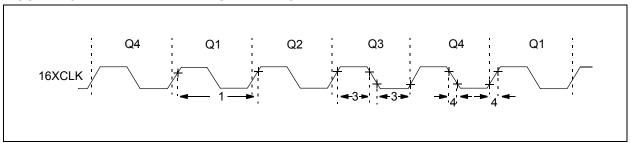


TABLE 4-3: EXTERNAL CLOCK TIMING REQUIREMENTS

AC Cha	racteristic	s	Standard Operating Conditions (unless otherwise specified) Operating Temperature: $-40^{\circ}\text{C} \le \text{Ta} \le +125^{\circ}\text{C}$ (Extended) Operating Voltage VDD range is described in Section 4.1 "DC Characteristics"				
Param. No.	Conditions						
1	TXCLK	External 16XCLK Period (2, 3)	542.5	_	_	ns	
1A	Fxclk	External 16XCLK Frequency <sup>(2, 3)</sup>	DC	_	1.8432	MHz	
1C	Exclk	Clock Error (4, 5)	_	_	±2	%	Note 5
3	,	Clock in (16XCLK) Low or High Time	50	_	_	ns	
4	TXCLKR, TXCLKF	Clock in (16XCLK) Rise or Fall Time <sup>(5)</sup>	_	_	7.5	ns	Note 5

**Note 1:** Data in the Typical ("Typ") column is at 5V, +25°C, unless otherwise stated. These parameters are for design guidance only and are not tested.

- 2: All specified values are based on characterization data for that particular oscillator type under standard operating conditions with the device executing code. Exceeding these specified limits may result in an unstable oscillator operation and/or higher than expected current consumption.

  When an external clock input is used, the "max" cycle time limit is "DC" (no clock) for all devices.
- **3:** A duty cycle of no more than 60/40 (High Time/Low Time or Low Time/High Time) is recommended for external clock inputs.
- **4:** This is the clock error from the desired clock frequency. The total system clock error includes the error from the transmitter and the error of receiver (from the desired clock frequency). If the transmitter is 2% fast from the target frequency and the receiver is 2% slow from the target frequency, then the total error is 4%.
- **5:** These parameters (shaded) are characterized but are not tested. These values should be used for design guidance only.

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### FIGURE 4-4: I/O WAVEFORM

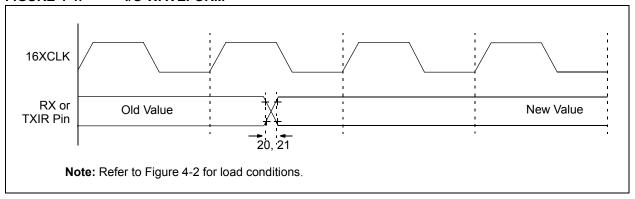
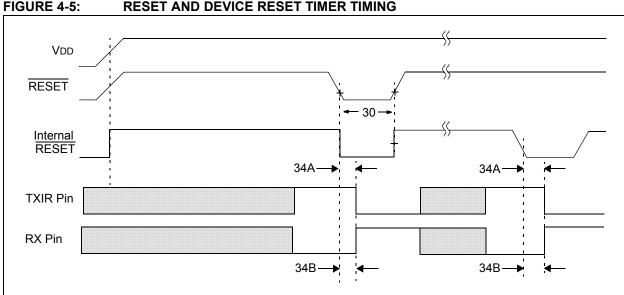


TABLE 4-4: I/O TIMING REQUIREMENTS

AC Characteristics			Standard Operating Conditions (unless otherwise specified) Operating Temperature: $-40^{\circ}\text{C} \le \text{TA} \le +125^{\circ}\text{C}$ (Extended) Operating Voltage VDD range is described in Section 4.1 "DC Characteristics"						
Param. No.	Sym	Characteristic	Min Typ (1) Max Units Conditions						
20A	ToR	RX pin rise time (2, 3)	_	10	25	ns	V <sub>DD</sub> ≥ 2.7V ( <b>Note 3</b> )		
20B			_	10	60	ns	VDD = 1.8V (Note 3)		
20C		TXIR pin rise time (2, 3)	-	10	25	ns	VDD ≥ 2.7V ( <b>Note 3</b> )		
20D				10	60	ns	VDD = 1.8V (Note 3)		
21A	ToF	RX pin fall time (2, 3)	_	10	35	ns	Note 3		
21C		TXIR pin fall time (2, 3)	_	10	25	ns	Note 3		

**Note 1:** Data in the Typical ("Typ") column is at 5V, +25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

- 2: See Figure 4-2 for loading conditions.
- **3:** These parameters (shaded) are characterized but are not tested. These values should be used for design guidance only.



**RESET AND DEVICE RESET TIMER TIMING** FIGURE 4-5:

**RESET AND DEVICE RESET TIMER REQUIREMENTS TABLE 4-5**:

AC Chai	racteristic	s	Standard Operating Conditions (unless otherwise specified) Operating Temperature: $-40^{\circ}\text{C} \le \text{TA} \le +125^{\circ}\text{C}$ (Extended) Operating Voltage VDD range is described in Section 4.1 "DC Characteristics".				
Param. No.	Sym	Characteristic	Min	Typ <sup>(1)</sup>	Max	Units	Conditions
30	TRSTL	RESET Pulse Width (low)	2000	_		ns	VDD = 5.0 V
34A	Tod	Default output state of TXIR pin from RESET Low	_		2	μs	
34B	Tod	Default output state of RX pins from RESET Low	_	_	2	μs	

**Note 1:** Data in the Typical ("Typ") column is at 5V, +25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

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FIGURE 4-6: TX AND TXIR WAVEFORMS

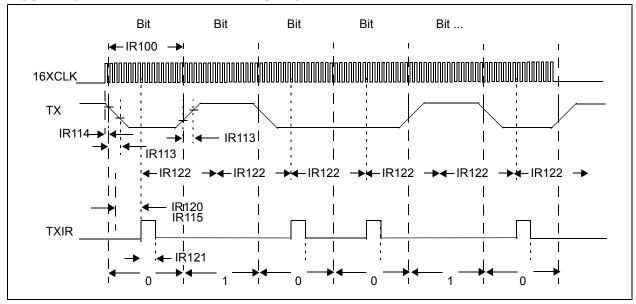
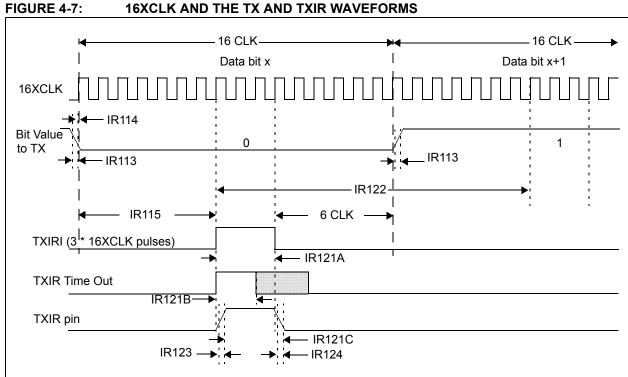


TABLE 4-6: TX AND TXIR REQUIREMENTS

AC Chai	racteristics		Standard Operating Conditions (unless otherwise specified) Operating Temperature: $-40^{\circ}\text{C} \le \text{Ta} \le +125^{\circ}\text{C}$ (Extended) Operating Voltage VDD range is described in <b>Section 4.1 "DC Characteristics"</b> .					
Param. No.	Sym	Characteristic	Min	Typ <sup>(1)</sup>	Max	Units	Conditions	
IR100A	Ттхвіт	Transmit Baud Rate	_	16		TXCLK		
IR100B	TTXIRBIT	Transmit Baud Rate	16		16	TXCLK		
IR102A	Етхвіт	Host UART TX Error	_	_	± 2	%	Note 2, 3	
IR102B	ETXIRBIT	TXIR Error from 16XCLK	_	0	l	%	Note 2, 4	
IR113	TTXRF	TX pin rise time and fall time	_		25	ns	Note 2	
IR114	TtxpdirJ	16XCLK to TX jitter	_	_	1	TXCLK	Note 2	
IR120	TTXL2TXIRH	TX falling edge ( $\downarrow$ ) to TXIR rising edge ( $\uparrow$ ) <sup>(1)</sup>	7		8	TXCLK		
IR121A	TTXIRPW	TXIR pulse width	3	_	3	TXCLK	At 115200 baud	
IR121B			1.41	3.5	5	μs	At 9600 baud (Note 5)	
IR122	TTXIRP	TXIR bit period (1)	_	16		TXCLK		
IR123	TTXIRRF	TXIR pin rise time and fall time	_	_	10	ns	50 pF load (Note 2)	

**Note 1:** Data in the Typical ("Typ") column is at 5V, +25°C, unless otherwise stated. These parameters are for design guidance only and are not tested.

- **2:** These parameters (shaded) are characterized but are not tested. These values should be used for design guidance only.
- **3:** The TX pin operation may be asynchronous to the 16XCLK pin. This is the error from the desired baud rate for the system.
- **4:** The TXIR pin operation is synchronous to the 16XCLK pin. Any error present on the 16XCLK pin (Parameter 1C) will be refelected on the TXIR pin.
- 5: This specification is not tested. This value is from the design target.



**16XCLK AND THE TX AND TXIR WAVEFORMS** 

**TABLE 4-7: TX AND TXIR REQUIREMENTS** 

AC Cha	racteristics		Standard Operating Conditions (unless otherwise specified) Operating Temperature: $-40^{\circ}C \le TA \le +125^{\circ}C$ (Extended) Operating Voltage VDD range is described in <b>Section 4.1 "DC Characteristics"</b> .					
Param. No.	Symbol	Characteristic	Conditions					
IR113	TTXRF	TX pin rise time and fall time	_	_	25	ns	Note 2	
IR114	T⊤xJ	TX to 16XCLK jitter	_		1	TXCLK	Note 2	
IR120	TTXL2TXIRH	TX falling edge ( $\downarrow$ ) to TXIR rising edge ( $\uparrow$ ) <sup>(1)</sup>	7		8	TXCLK		
	TTXIRPW	TXIR pulse width	Smaller of		Smaller of			
IR121A			3	_	3	TXCLK	At 115200 baud	
IR121B			1.41	3.5	5	μs	At 9600 baud (Note 3)	
IR122	TTXIRP	TXIR bit period	_	16		TXCLK		
20C	TTXIRR	TXIR pin rise time	_	10	25	ns	VDD ≥ 2.7V ( <b>Note 2</b> )	
20D			_	10	60	ns	VDD = 1.8V (Note 2)	
21C	TTXIRF	TXIR pin fall time	_	10	25	ns	Note 2	

Note 1: Data in the Typical ("Typ") column is at 5V, +25°C, unless otherwise stated. These parameters are for design guidance only and are not tested.

- 2: These parameters (shaded) are characterized but are not tested. These values should be used for design guidance only.
- 3: This specification is not tested. This value is from the design target

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FIGURE 4-8: RXIR AND RX WAVEFORMS

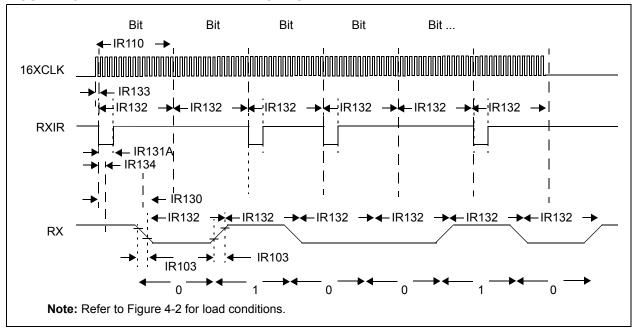


TABLE 4-8: RXIR REQUIREMENTS

AC Cha	racteristics		Standard Operating Conditions (unless otherwise specified) Operating Temperature: $-40^{\circ}\text{C} \le \text{TA} \le +125^{\circ}\text{C}$ (Extended) Operating Voltage VDD range is described in <b>Section 4.1 "DC Characteristics"</b> .					
Param. No.	Sym	Characteristic	Conditions					
IR101A	ERXIRBIT	RXIR Error	_	_	± 2	%	Note 2, 3	
IR101B	ERXBIT	Host UART RX Error	_	0	1	%	Note 2, 4	
IR103	TTXRF	RX pin rise time and fall time	_		25	ns		
IR110	TRXBIT	Receive (RX pin) Bit Rate	16	1	16	TXCLK		
IR130	TRXIRL2RXH	RXIR Low AND 16XCLK	_	4	1	TXCLK	At 115,200 baud	
		edge ( $\downarrow$ or $\uparrow$ ) to RX falling edge ( $\downarrow$ )	_	3		Txclk	At 9600 baud	
IR131A	TRXIRPW	RXIR pulse width	1.41		3 TXCLK	μs		
IR132	TRXIRP	RXIR bit period (1)	_	16		TXCLK		
IR133	TRXIRJ	16XCLK to RXIR jitter	_	_	1	TXCLK	Note 2	
IR134	TRXSKW	16XCLK to RX skew	_		2.5	μs		
IR135	TRXPDFIL	RXIR Filter	0.7		1.4	μs	Note 5	

- **Note 1:** Data in the Typical ("Typ") column is at 5V, +25°C, unless otherwise stated. These parameters are for design guidance only and are not tested.
  - 2: These parameters (shaded) are characterized but are not tested. These values should be used for design guidance only.
  - **3:** The RXIR pin operation is asynchronous to the 16XCLK pin. This is the error from the desired baud rate for the system.
  - **4:** The RX pin operation is synchronous to the 16XCLK pin. Any error present on the 16XCLK pin (Parameter 1C) will be refelected on the RX pin.
  - 5: The minimum specification ensures that ALL pulses less then this pulse width are rejected, the maximum specification ensures that ALL pulses greater than this pulse width are never rejected, and pulse widths between these may or may not be rejected.

### 5.0 DC AND AC CHARACTERISTICS GRAPHS AND TABLES

The graphs and tables are not available at this time

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NOTES:

### 6.0 PACKAGING INFORMATION

### 6.1 Package Marking Information

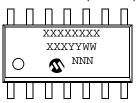
## 8-Lead PDIP (300 mil)



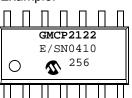
### Example:



### 8-Lead SOIC (150 mil)



### Example:



Legend: XX...X Customer specific information\*

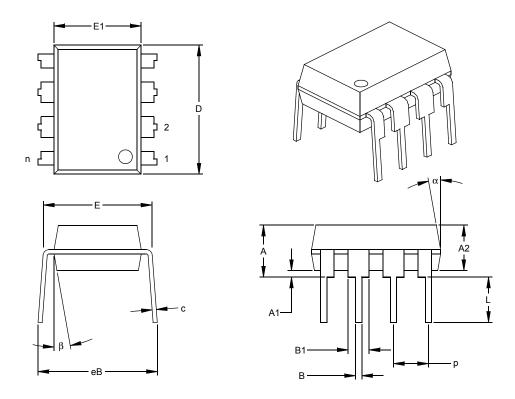
Y Year code (last digit of calendar year)
YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')

NNN Alphanumeric traceability code

**Note**: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line thus limiting the number of available characters for customer specific information.

\* Standard device marking consists of Microchip part number, year code, week code, and traceability code..

## 8-Lead Plastic Dual In-line (P) - 300 mil Body (PDIP)



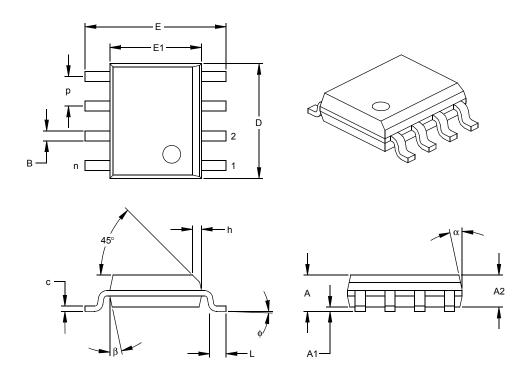
	Units		INCHES*		MILLIMETERS		
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8			8	
Pitch	р		.100			2.54	
Top to Seating Plane	Α	.140	.155	.170	3.56	3.94	4.32
Molded Package Thickness	A2	.115	.130	.145	2.92	3.30	3.68
Base to Seating Plane	A1	.015			0.38		
Shoulder to Shoulder Width	Е	.300	.313	.325	7.62	7.94	8.26
Molded Package Width	E1	.240	.250	.260	6.10	6.35	6.60
Overall Length	D	.360	.373	.385	9.14	9.46	9.78
Tip to Seating Plane	L	.125	.130	.135	3.18	3.30	3.43
Lead Thickness	С	.008	.012	.015	0.20	0.29	0.38
Upper Lead Width	B1	.045	.058	.070	1.14	1.46	1.78
Lower Lead Width	В	.014	.018	.022	0.36	0.46	0.56
Overall Row Spacing §	eB	.310	.370	.430	7.87	9.40	10.92
Mold Draft Angle Top	α	5	10	15	5	10	15
Mold Draft Angle Bottom	β	5	10	15	5	10	15

Notes: Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

.010" (0.254mm) per side. JEDEC Equivalent: MS-001 Drawing No. C04-018

<sup>\*</sup> Controlling Parameter § Significant Characteristic

## 8-Lead Plastic Small Outline (SN) - Narrow, 150 mil Body (SOIC)



		INCHES*		MILLIMETERS			
Dimensior	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8			8	
Pitch	р		.050			1.27	
Overall Height	Α	.053	.061	.069	1.35	1.55	1.75
Molded Package Thickness	A2	.052	.056	.061	1.32	1.42	1.55
Standoff §	A1	.004	.007	.010	0.10	0.18	0.25
Overall Width	Е	.228	.237	.244	5.79	6.02	6.20
Molded Package Width	E1	.146	.154	.157	3.71	3.91	3.99
Overall Length	D	.189	.193	.197	4.80	4.90	5.00
Chamfer Distance	h	.010	.015	.020	0.25	0.38	0.51
Foot Length	L	.019	.025	.030	0.48	0.62	0.76
Foot Angle	ф	0	4	8	0	4	8
Lead Thickness	С	.008	.009	.010	0.20	0.23	0.25
Lead Width	В	.013	.017	.020	0.33	0.42	0.51
Mold Draft Angle Top	α	0	12	15	0	12	15
Mold Draft Angle Bottom	β	0	12	15	0	12	15

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

.010" (0.254mm) per side.
JEDEC Equivalent: MS-012
Drawing No. C04-057

<sup>\*</sup> Controlling Parameter § Significant Characteristic

NOTES:

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To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO.	<u> </u>		<u>/XX</u>	<u>X</u>	Exa	mples:	
   Device Tem	 nperati	ıre	 Package	 Lead Finish	a)	MCP2122-E/PG:	Extended Temperature, PDIP package, Pb-free
F	Range				b)	MCP2122-E/SNG:	Extended Temperature, SOIC package, Pb-free
Device	MCP2	122: li	nfrared Encode	er/Decoder	c)	MCP2122T-E/SNG:	Tape and Reel, Extended Temperature, SOIC package. Pb-free
Temperature Range	E	= -4	40°C to +125	S°C			
Package	P SN	= =		300 mil, Body), 8-lead (150 mil, Body), 8-lead			
Lead Finish	G	=	Matte Tin (Pu	ure Sn)			

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05/28/04